

<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10595310	YAMASHITA ET AL.
<b>Examiner</b>  SING P CHAN	Art Unit	
		1791

SEARCHED			
Class	Subclass	Date	Examiner
156	230-235, 246, 247	10/10/08	SPC
428	469, 472	10/10/08	SPC
156	230-235, 246, 247	3/9/09	SPC
428	469, 472	3/9/09	SPC
156	230-235, 246, 247	9/3/09	SPC
428	469, 472	9/3/09	SPC
156	230-235, 246, 247	1/27/10	SPC
428	439, 472	1/27/10	SPC
156	230-235, 246, 247	10/1/10	SPC
428	439, 472	10/1/10	SPC
156	230-235, 246, 247	2/3/11	SPC
428	439, 472	2/3/11	SPC

SEARCH NOTES			
Search Notes	Date	Examiner	
Text and image search on EAST	10/10/08	SPC	
Inventors search on EAST and PALM akio yamashita, yumiko fukumoto, and yuugo goto	10/10/08	SPC	
Text and image search on EAST	3/9/09	SPC	
Inventors search on EAST and PALM on akio yamashita, yumiko fukumoto, and yuugo goto	3/9/09	SPC	
Text and image search on EAST	9/3/09	SPC	
Inventors search on EAST and PALM akio yamashita, yumiko fukumoto, and yuugo goto	9/3/09	SPC	
Text and image search on EAST	1/27/10	SPC	
Inventors search on EAST and PALM akio yamashita, yumiko fukumoto, and yuugo goto	1/27/10	SPC	
Text and image search on EAST	10/1/10	SPC	
Inventors search on EAST and PALM akio yamashita, yumiko fukumoto, and yuugo goto	10/1/10	SPC	
Text and image search on EAST	2/3/11	SPC	
Inventors search on EAST and PALM akio yamashita, yumiko fukumoto, and yuugo goto	2/3/11	SPC	

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**INTERFERENCE SEARCH**

Class	Subclass	Date	Examiner